

1N4148

PRV : 100 Volts Io : 150 mA

FEATURES:

- * Silicon Epitaxial Planar Diode
- * High reliability
- * Low reverse current
- * Low forward voltage drop
- * High speed switching
- * Pb / RoHS Free

MECHANICAL DATA:

* Case: DO-35 Glass Case

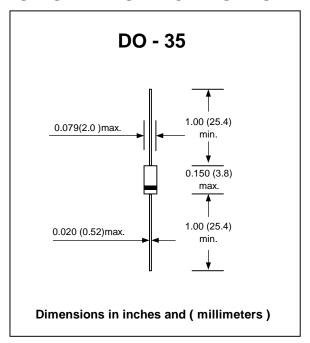
 Lead : Axial lead solderable per MIL-STD-202, Method 208 guaranteed

* Polarity: Color band denotes cathode end

* Mounting position : Any

* Weight: 0.13 gram (approximately)

HIGH SPEED SWITCHING DIODE



MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Rating at 25 $^{\circ}$ C ambient temperature unless otherwise specified. Single phase, half wave, 60 Hz, resistive or inductive load. For capacitive load, derate current by 20%.

RATING	SYMBOL	VALUE	UNIT
Maximum Repetitive Peak Reverse Voltage	VRRM	100	V
Maximum Reverse Voltage	VR	75	V
Maximum Average Forward Current	lf(AV)	150 ¹⁾	mA
Maximum Surge Forward Current at t < 1s and Tj = 25°C	İfsm	500	mA
Maximum Power Dissipation , Ta = 25 °C	PD	500	mW
Maximum Forward Voltage at I _F = 10 mA	VF	1.0	V
Maximum Reverse Current at VR = 20V	lr	25	nA
at VR = 75V		5	μΑ
at VR = 20V, Tj = 150°C		50	μΑ
Maximum Voltage Rise when switching ON			
test with 50mA Pulses	Vfr	2.5	V
$tp = 0.1\mu s$, Rise Time <30ns fp = 5 to 100kHz			
Maximum Reverse Recovery Time	Trr	4	ns
from IF = 10mA to IR = 1mA , VR = 6V , RL = 100 Ω			
Thermal Resistance Junction to Ambient Air	RθJA	350 ¹⁾	K/W
Junction Temperature Range	TJ	175	°C
Storage Temperature Range	Тѕтс	- 65 to + 175	°C

Note: 1) Valid provided that leads at a distance of 8 mm from case are kept at ambient temperature (DO-35)

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RATING AND CHARACTERISTIC CURVES (1N4148)

FIG.1 - DERATING CURVE FOR OUTPUT RECTIFIED CURRENT

250

200

200

100

25 50 75 100 125 150 175

AMBIENT TEMPERATURE, (°C)

FIG.2 - POWER DARATING CURVE

500
400
400
200
100
0
25 50 75 75 100 125 150 175

AMBIENT TEMPERATURE, (°C)

FIG.3 - TYPICAL FORWARD CHARACTERISTICS

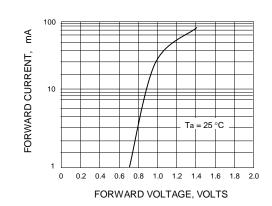
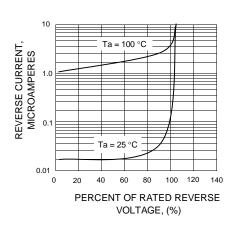


FIG.4 - TYPICAL REVERSE CHARACTERISTICS



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